





SN54AHCT574, SN74AHCT574

JAJSQS8N - OCTOBER 1995 - REVISED JULY 2024

SNx4AHCT5743ステート出力、オクタルトランスペアレントDタイプラッ チ

1 特長

- 入力は TTL 電圧互換
- JESD 17 準拠で 250mA 超のラッチアップ性能
- MIL-PRF-38535 準拠の製品については、特に記述 のない限り、すべてのパラメータはテスト済みです。 その他のすべての製品については、量産プロセスにす べてのパラメータのテストが含まれているとは限りませ
- JESD 22 を上回る ESD 保護
 - 2000V、人体モデル (A114-A)
 - 1000V、デバイス帯電モデル (C101)

2 アプリケーション

- スマートフォン ハンドセット
- PDA
- ネットワーク スイッチ
- ウェアラブルなヘルスケア/フィットネス機器
- テレビ (LCD)
- 電源インフラストラクチャ

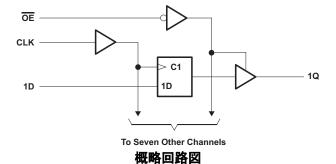
3 概要

SNx4AHCT574 デバイスは、オクタル エッジ トリガ D タイ プ フリップフロップで、大きい容量性負荷または比較的低 いインピーダンスの負荷の駆動用に設計された3ステート 出力を備えています。

製品情報

部品番号	パッケージ ⁽¹⁾	パッケージ サイズ ⁽²⁾	本体サイズ ⁽³⁾		
	DB (SSOP, 20)	7.2mm × 7.8mm	7.50mm × 5.30mm		
	DGV (TVSOP, 20)	5.00mm × 6.4mm	5.00mm × 4.40mm		
SNx4AHCT574	DW (SOIC, 20)	12.80mm × 10.3mm	12.8mm × 7.5mm		
	N (PDIP, 20)	24.33mm × 9.4mm	25.40mm × 6.35mm		
	PW (TSSOP, 20)	6.50mm × 6.4mm	6.50mm × 4.40mm		

- 詳細については、セクション 11 を参照してください。
- パッケージ サイズ (長さ×幅) は公称値であり、該当する場合はピ (2) ンも含まれます。
- 本体サイズ (長さ×幅) は公称値であり、ピンは含まれません。



English Data Sheet: SCLS245



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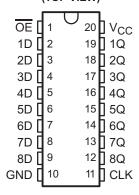
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4 Pin Configuration and Functions

SN54AHCT574 . . . J OR W PACKAGE SN74AHCT574 . . . DB, DGV, DW, N, NS, OR PW PACKAGE (TOP VIEW)





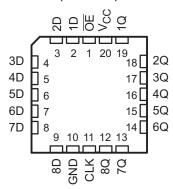


表 4-1. Pin Functions

	PIN	1/0	DESCRIPTION
NO.	NAME	I/O	DESCRIPTION
1	ŌĒ	I	Output Enable
2	1D	I	1D Input
3	2D	I	2D Input
4	3D	I	3D Input
5	4D	I	4D Input
6	5D	I	5D Input
7	6D	I	6D Input
8	7D	I	7D Input
9	8D	I	8D Input
10	GND	_	Ground Pin
11	CLK	I	Clock Pin
12	8Q	0	8Q Output
13	7Q	0	7Q Output
14	6Q	0	6Q Output
15	5Q	0	5Q Output
16	4Q	0	4Q Output
17	3Q	0	3Q Output
18	2Q	0	2Q Output
19	1Q	0	1Q Output
20	V _{CC}	_	Power Pin



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
VI	Input voltage range ⁽²⁾		-0.5	7	V
Vo	Output voltage range ⁽²⁾		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V _I < 0		-20	mA
I _{OK}	Output clamp current	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
Io	Continuous output current	$V_{O} = 0$ to V_{CC}		±25	mA
	Continuous current through V _{CC} or GND			±50	mA
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			Value	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2000	
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

		SN54AHC	T574	SN74AHCT574		UNIT
		MIN	MAX	MIN	MIN MAX	
V _{CC}	Supply voltage	4.5	5.5	4.5	5.5	V
V _{IH}	High-level input voltage	2		2		V
V _{IL}	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	5.5	0	5.5	V
Vo	Output voltage	0	V _{CC}	0	V _{CC}	V
I _{OH}	High-level output current		-8		-8	mA
I _{OL}	Low-level output current		8		8	mA
Δt/Δν	Input transition rise or fall rate		20		20	ns/V
T _A	Operating free-air temperature	– 55	125	-40	125	°C

All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs (SCBA004).

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⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



5.4 Thermal Information

				SN74AH0	CT574				
	THERMAL METRIC ⁽¹⁾ DW (SOIC) DB (SSOP) OR (TVSOP) N (PDIP) NS (SOP) PW (TSSOP)								
		20 PINS							
$R_{\theta JA}$	Junction-to-ambient thermal resistance	81.1	97.9	117.2	53.3	79.2	116.8		
R ₀ JC(top)	Junction-to-case (top) thermal resistance	48.9	59.6	32.7	40.0	45.7	58.5		
$R_{\theta JB}$	Junction-to-board thermal resistance	53.8	53.1	58.7	34.2	46.8	78.7	°C/W	
ΨЈТ	Junction-to-top characterization parameter	19.5	21.3	1.15	26.4	19.3	12.6	C/VV	
Ψ_{JB}	Junction-to-board characterization parameter	53.1	52.7	58.0	34.1	46.4	77.9		
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	N/A	N/A		

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

5.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{cc}	V _{CC} T _A = 25°C		SN54AHCT574		-40°C to 85°C SN74AHCT574		-40°C to 125°C SN74AHCT574		UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
V	I _{OH} = -50 μA	4.5 V	4.4	4.5		4.4		4.4		4.4		V
V _{OH}	I _{OH} = -8 mA	4.5 V	3.94			3.8		3.8		3.8		v
V	I _{OL} = 50 μA	4.5 V			0.1		0.1		0.1		0.1	V
V _{OL}	I _{OL} = 8 mA	4.5 V			0.36		0.44		0.44		0.44	v
l _l	V _I = 5.5 V or GND	0 V to 5.5 V			±0.1		±1 ⁽¹⁾		±1		±1	μA
l _{oz}	V _O = V _{CC} or GND	5.5 V			±0.25		±2.5		±2.5		±2.5	μA
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		40		40		40	μA
ΔI _{CC} (2)	One input at 3.4 V, Other inputs at V _{CC} or GND	5.5 V			1.35		1.5		1.5		1.5	mA
C _i	V _I = V _{CC} or GND	5 V		3	10				10			pF
Co	V _O = V _{CC} or GND	5 V		3								pF

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested at $V_{CC} = 0 \text{ V}$.

5.6 Timing Requirements

over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

		T _A = 25	3°C	SN54AHC	T574	SN74AHC	T574	T _A = -40°C to 125°C SN74AHCT574 MIN MAX		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX			
t _w	Pulse duration, LE high	5.5		5.5		5.5		5.5		ns
t _{su}	Setup time, data before LE \downarrow	3.5		3.5		3.5		3.5		ns
t _h	Hold time, data after LE \downarrow	1.5		1.5		1.5		1.5		ns

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⁽²⁾ This is the increase in supply current for each input at one of the specified TTL voltage levels, rather than 0 V or V_{CC}.



5.7 Switching Characteristics

over recommended operating free-air temperature range, $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (OUTPUT)	TO (INPUT)	LOAD CAPACITANCE	1	Γ _A = 25°C		SN54AH	CT574	SN74AHCT574		T _A = -40°C to 125°C SN74AHCT574		UNIT				
	(001701)	(INFOT)	CAFACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	MIN	MAX					
			C _L = 15 pF	130 ⁽¹⁾	180 ⁽¹⁾		110 ⁽¹⁾		110		110		ns				
f _{max}			C _L = 50 pF	85	115		75		75		75		115				
t _{PLH}	CLK	Q	C ₁ = 15 pF		5.5 ⁽¹⁾	8.6 ⁽¹⁾	1(1)	10 ⁽¹⁾	1	10	1	11	ns				
t _{PHL}	CLK Q	C _L = 15 pr		5.5 ⁽¹⁾	8.6 ⁽¹⁾	1(1)	10 ⁽¹⁾	1	10	1	11	ns					
t _{PZH}	- OE	ŌE Q	C ₁ = 15 pF		5 ⁽¹⁾	9(1)	1 ⁽¹⁾	10.5 ⁽¹⁾	1	10.5	1	11.5	ns				
t _{PZL}			Q	Q	Q	Q	Q	Q	GL = 15 pr		5 ⁽¹⁾	9(1)	1 ⁽¹⁾	10.5 ⁽¹⁾	1	10.5	1
t _{PHZ}	OE	ŌE Q	C = 15 = E		5.5 ⁽¹⁾	9(1)	1(1)	10.5 ⁽¹⁾	1	10.5	1	11.5	ns				
t _{PLZ}		Q	C _L = 15 pF		5.5 ⁽¹⁾	9(1)	1(1)	10.5 ⁽¹⁾	1	10.5	1	11.5	115				
t _{PLH}	CLK	Q	C ₁ = 50 pF		7	10.6	1	12	1	12	1	13	ns				
t _{PHL}	OLK	Q	О_ – 50 рі		7	10.6	1	12	1	12	1	13	115				
t _{PZH}	OE	Q	C ₁ = 50 pF		6	11	1	12.5	1	12.5	1	13.5	ns				
t _{PZL}	- OE	Q	GL = 50 pF		6	11	1	12.5	1	12.5	1	13.5	115				
t _{PHZ}	OF	ŌE Q	0 0 50 5		7	10.1	1	11.5	1	11.5	1	13	ns				
t _{PLZ}			C _L = 50 pF		7	10.1	1	11.5	1	11.5	1	13	115				
t _{sk(o)}			C _L = 50 pF			1 ⁽²⁾				1			ns				

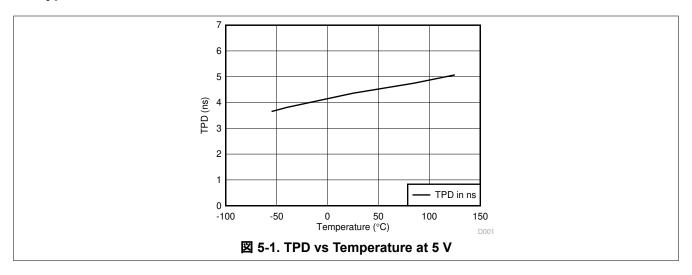
- (1) On products compliant to MIL-PRF-38535, this parameter is not production tested.
- (2) On products compliant to MIL-PRF-38535, this parameter does not apply.

5.8 Operating Characteristics

 $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$

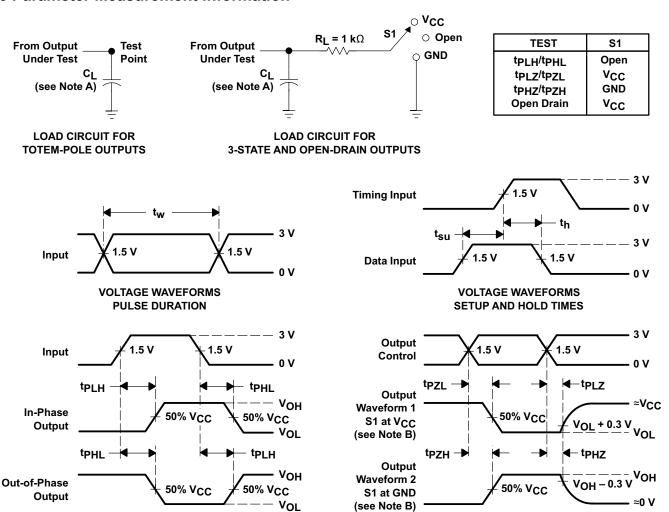
PARAMETER		TEST CO	TYP	UNIT	
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	28	pF

5.9 Typical Characteristics





6 Parameter Measurement Information



NOTES: A. C_I includes probe and jig capacitance.

VOLTAGE WAVEFORMS

PROPAGATION DELAY TIMES

INVERTING AND NONINVERTING OUTPUTS

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

図 6-1. Load Circuit and Voltage Waveforms

VOLTAGE WAVEFORMS

ENABLE AND DISABLE TIMES

LOW- AND HIGH-LEVEL ENABLING

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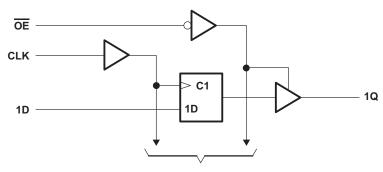
7 Detailed Description

7.1 Overview

The SNx4AHCT574 devices are octal edge-triggered D-type flip-flops that feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. These devices are particularly suitable for implementing buffer registers, IO ports, bidirectional bus drivers, and working registers.

Regarding the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels of the data (D) inputs. A buffered output-enable (\overline{OE}) input places the eight outputs in either a normal logic state (high or low) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without interface or pull-up components.

7.2 Functional Block Diagram



To Seven Other Channels

7.3 Feature Description

- TTL inputs
 - Lowered switching threshold allows up translation 3.3 V to 5 V
- · Slow edges reduce output ringing

7.4 Device Functional Modes

表 7-1. Function Table (Each Flip-Flop)

	INPUTS	INPUTS							
ŌĒ	CLK	D	OUTPUT Q						
L	1	Н	Н						
L	\uparrow	L	L						
L	H or L	Х	Q_0						
н	X	Χ	Z						



8 Application and Implementation

注

以下のアプリケーション情報は、TIの製品仕様に含まれるものではなく、TIではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくことになります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

8.1 Application Information

The SN74AHCT574 is a low-drive CMOS device that can be used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs. The input switching levels have been lowered to accommodate TTL inputs of 0.8-V V_{IL} and 2-V V_{IH} . This feature makes the device ideal for translating up from 3.3 V to 5 V. \boxtimes 8-2 shows this type of translation.

8.2 Typical Application

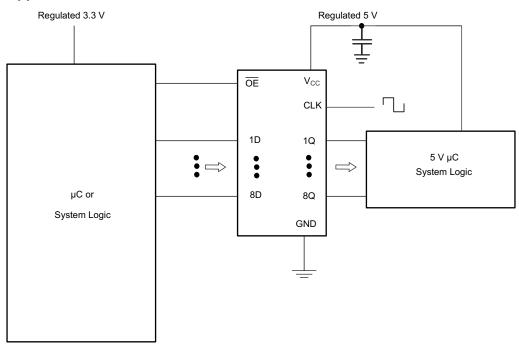


図 8-1. Typical Application Schematic

8.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads; therefore, routing and load conditions should be considered to prevent ringing.

8.2.2 Detailed Design Procedure

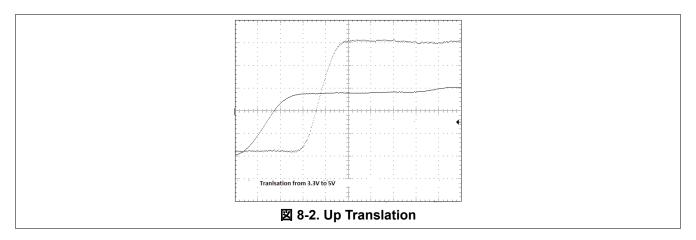
- Recommended input conditions
 - Rise time and fall time specs: See (Δt/ΔV) in the セクション 5.3 table.
 - Specified High and low levels: See (V_{IH} and V_{IL}) in the $\frac{1}{2}$ 5.3 table.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC}.
- 2. Recommend output conditions
 - Load currents should not exceed 25 mA per output and 75 mA total for the part.
 - Outputs should not be pulled above V_{CC}.

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資料に関するフィードバック(ご意見やお問い合わせ) を送信

9

8.2.3 Application Curves



8.3 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the セクション 5.3 table.

Each V_{CC} pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1 μ F bypass capacitor is recommended. If there are multiple V_{CC} pins, 0.01 μ F or 0.022 μ F is recommended for each power pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

8.4 Layout

8.4.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified in \boxtimes 8-3 are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} ; whichever makes more sense or is more convenient. It is generally acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the outputs section of the part when asserted. This will not disable the input section of the IO's so they cannot float when disabled.

8.4.2 Layout Example

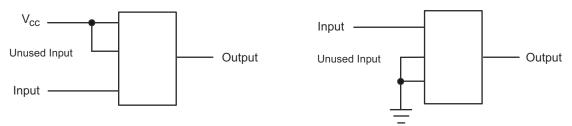


図 8-3. Layout Diagram



9 Device and Documentation Support

9.1 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jp のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。 変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

9.2 サポート・リソース

テキサス・インスツルメンツ E2E[™] サポート・フォーラムは、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計で必要な支援を迅速に得ることができます。

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9.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

表 9-1. Related Links

PARTS	PRODUCT FOLDER SAMPLE & BUY		TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN54AHCT574	Click here	Click here	Click here	Click here	Click here
SN74AHCT574	Click here	Click here	Click here	Click here	Click here

9.4 Trademarks

テキサス・インスツルメンツ E2E™ is a trademark of Texas Instruments. すべての商標は、それぞれの所有者に帰属します。

9.5 静電気放電に関する注意事項



この IC は、ESD によって破損する可能性があります。テキサス・インスツルメンツは、IC を取り扱う際には常に適切な注意を払うことを推奨します。正しい取り扱いおよび設置手順に従わない場合、デバイスを破損するおそれがあります。

ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

9.6 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

10 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

C	hanges from Revision M (September 2014) to Revision N (July 2024)	Page
•	ドキュメント全体にわたって表、図、相互参照の採番方法を更新	1
•	「特長」からマシン モデルを削除	1
•	Updated RθJA values: PW = 103.3 to 116.8, DW = 79.4 to 81.1; Updated PW and DW packages for	
	RθJC(top), RθJB, ΨJT, ΨJB, and RθJC(bot), all values in °C/W	<mark>5</mark>
_		

Changes from Revision L (July 2003) to Revision M (September 2014)

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•	「注文情報」表を削除。	1
•	「特長」の一覧に軍事利用についての免責事項を追加。	1
•	Added Pin Functions table	3
•	Added Handling Ratings table	4
	Changed MAX operating temperature to 125°C in Recommended Operating Conditions table	
•	Added Thermal Information table	<mark>5</mark>
•	Added –40°C to 125°C for SN74AHCT574 in the Electrical Characteristics table	<mark>5</mark>
•	Added T _A = -40°C to 125°C for SN74AHCT574 in the Timing Requirements table	<mark>5</mark>
•	Added T _A = -40°C to 125°C for SN74AHCT574 in the Switching Characteristics table	<mark>6</mark>
•	Added Typical Characteristics	<mark>6</mark>
•	Added Application and Implementation section	9
•	Added Power Supply Recommendations and Layout sections	10

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9685301Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9685301Q2A SNJ54AHCT 574FK	Samples
5962-9685301QRA	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9685301QR A SNJ54AHCT574J	Samples
5962-9685301QSA	ACTIVE	CFP	W	20	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9685301QS A SNJ54AHCT574W	Samples
SN74AHCT574DBR	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB574	Samples
SN74AHCT574DBRE4	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB574	Samples
SN74AHCT574DGVR	ACTIVE	TVSOP	DGV	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB574	Samples
SN74AHCT574DW	OBSOLETE	SOIC	DW	20		TBD	Call TI	Call TI	-40 to 125	AHCT574	
SN74AHCT574DWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHCT574	Samples
SN74AHCT574N	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 125	SN74AHCT574N	Samples
SN74AHCT574NSR	ACTIVE	SOP	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHCT574	Samples
SN74AHCT574PW	OBSOLETE	E TSSOP	PW	20		TBD	Call TI	Call TI	-40 to 125	HB574	
SN74AHCT574PWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	HB574	Samples
SN74AHCT574PWRG4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HB574	Samples
SNJ54AHCT574FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9685301Q2A SNJ54AHCT 574FK	Samples
SNJ54AHCT574J	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9685301QR A SNJ54AHCT574J	Samples
SNJ54AHCT574W	ACTIVE	CFP	W	20	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9685301QS A	Samples

PACKAGE OPTION ADDENDUM

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Orderable Device	Status	Package Type	Package Drawing	Pins Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
						(6)				
									SNJ54AHCT574W	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54AHCT574, SN74AHCT574:

Catalog: SN74AHCT574

PACKAGE OPTION ADDENDUM

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Military: SN54AHCT574

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHCT574DBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74AHCT574DGVR	TVSOP	DGV	20	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHCT574DWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74AHCT574DWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74AHCT574NSR	SOP	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74AHCT574PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74AHCT574PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74AHCT574PWRG4	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1



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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHCT574DBR	SSOP	DB	20	2000	356.0	356.0	35.0
SN74AHCT574DGVR	TVSOP	DGV	20	2000	356.0	356.0	35.0
SN74AHCT574DWR	SOIC	DW	20	2000	356.0	356.0	45.0
SN74AHCT574DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74AHCT574NSR	SOP	NS	20	2000	367.0	367.0	45.0
SN74AHCT574PWR	TSSOP	PW	20	2000	353.0	353.0	32.0
SN74AHCT574PWR	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74AHCT574PWRG4	TSSOP	PW	20	2000	356.0	356.0	35.0

PACKAGE MATERIALS INFORMATION

www.ti.com 1-Jan-2025

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9685301Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9685301QSA	W	CFP	20	25	506.98	26.16	6220	NA
SN74AHCT574N	N	PDIP	20	20	506	13.97	11230	4.32
SNJ54AHCT574FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54AHCT574W	W	CFP	20	25	506.98	26.16	6220	NA





- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

DGV (R-PDSO-G**)

24 PINS SHOWN

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194 8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.

 D. Index point is provided on cap for terminal identification only.

 E. Falls within Mil—Std 1835 GDFP2—F20







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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